

THE PORTABLE *i-100*



Truly the next-generation instrument for your in-factory or mobile inspector, with application horizons defined only by your imagination



INTRODUCTION

The *i-100* uncovers new vistas for the ultrasonic inspector....for the first time, a truly portable, full-featured PC-based instrument is available for factory and field inspection applications.

The **ScanMaster** MCI user interface, based on the Windows 2000/XP® operating system, provides the operator with a flexible and versatile platform for inspection combined with reporting, networking and archiving capabilities.

Single or multi-channel instrument configurations offer the operator the capability to store an unlimited number of set-up files for different transducers and inspection practices.



Glue bond evaluation in the automotive industry



One instrument.... unlimited inspection vistas

HARDWARE CONFIGURATIONS

The *i-100* is available in four hardware configurations:

The *i-100HR* is the basic workhorse of the *i-100* line. With its 35MHz analog bandwidth, programmable square wave pulser, 95dB true gain, 50dB DAC and range of 3600mm (140") in steel, the *i-100HR* is well matched to the most challenging inspection applications.

Three additional hardware configurations are provided, each designed for a group of application specialties:

- The *i-100HF*, with an extended analog bandwidth of 75MHz, is intended for high-frequency applications.
- For manual inspection of large forgings or lossy composites, the *i-100XD* provides an extended dynamic range of 80dB.
- The *i-100 4P* is intended for those inspections requiring 2-8 channels.

SUMMARY PRODUCT DESCRIPTION – ALL MODELS

- Square-wave pulser preamplifier, 10-500nsec programmable pulse width
- 95dB true instrument gain, 0.2dB resolution, +/- 1dB linearity
- 50dB DAC with 160nsec step size, 20dB/160nsec slew rate, 500K steps
- Four hardware gates per channel
- Dynamic backwall tracking with backwall attenuator
- Storage and export of A-scan signals
- 2 x 3.8 Amp-hour internal battery supply with 'hot-swap' capability
- USB, parallel, VGA, PSA keyboard and mouse ports
- Dual digital I/O ports
- Approximate weight, including batteries, 8kg (17.7lbs)
- Multi-language capabilities: English, French, German, Italian, Spanish



EXPANSION CAPABILITIES – ALL MODELS

- 32 hardware gates per channel
- 8-port digital I/O
- FFT A-scan signal analysis
- Free-running B-scan
- Networking and database management
- Inspection reports per customer specification

APPLICATION SPECTRUM

- Flaw detection in metals, composites and plastic materials
- Wall and clad thickness measurements
- A and B-scan evaluation

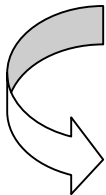
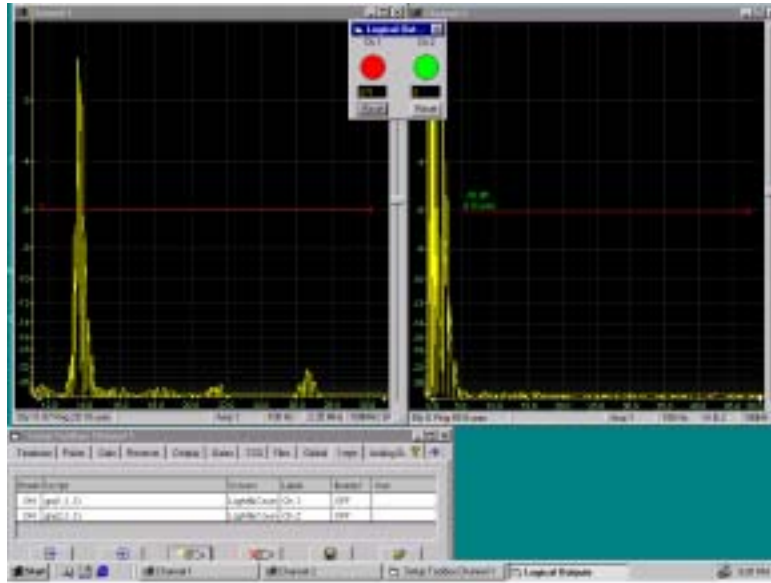


Spot weld inspection for the automotive industry

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Instrument operation made easy and efficient ...

... through windows-based inspection screens ...



... and intuitive dialog boxes for ultrasonic set-up!

Knobs look and work just like analog instrument controls

GAIN

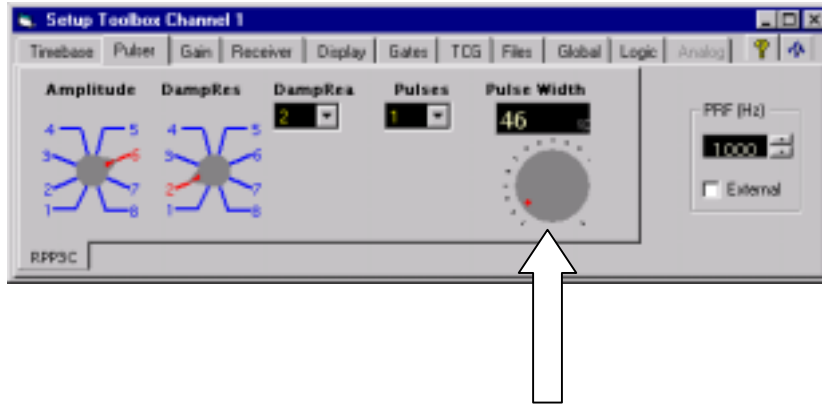
TIMEBASE DELAY AND RANGE

FREQUENCY FILTERS



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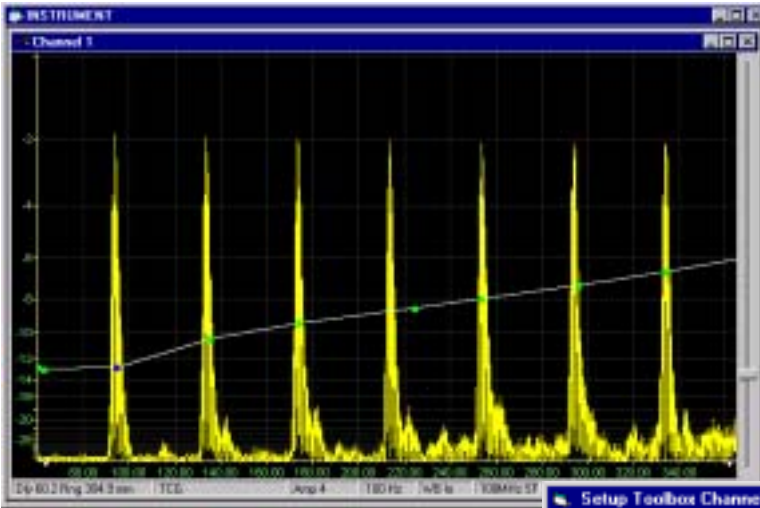
Tune the active transducer for enhanced near surface resolution.....
..... or maximum penetration power



.....simply by rotating this virtual dial.

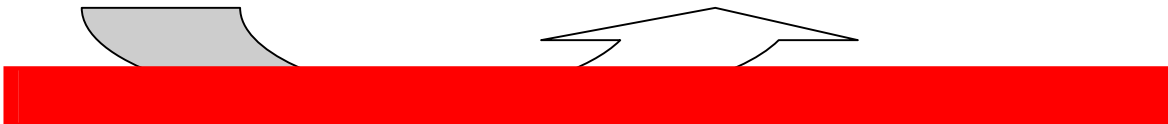
Using a focused 10MHz probe, resolve a No. 1 FBH at a depth of 0.060" in NI or Ti alloy, to a S/N greater than 20dB. Increase penetration power of contact and immersion probes by up to 9dB with square-wave excitation pulse tuning.

Set TCG requirements directly on the screen display using the control cursor.....



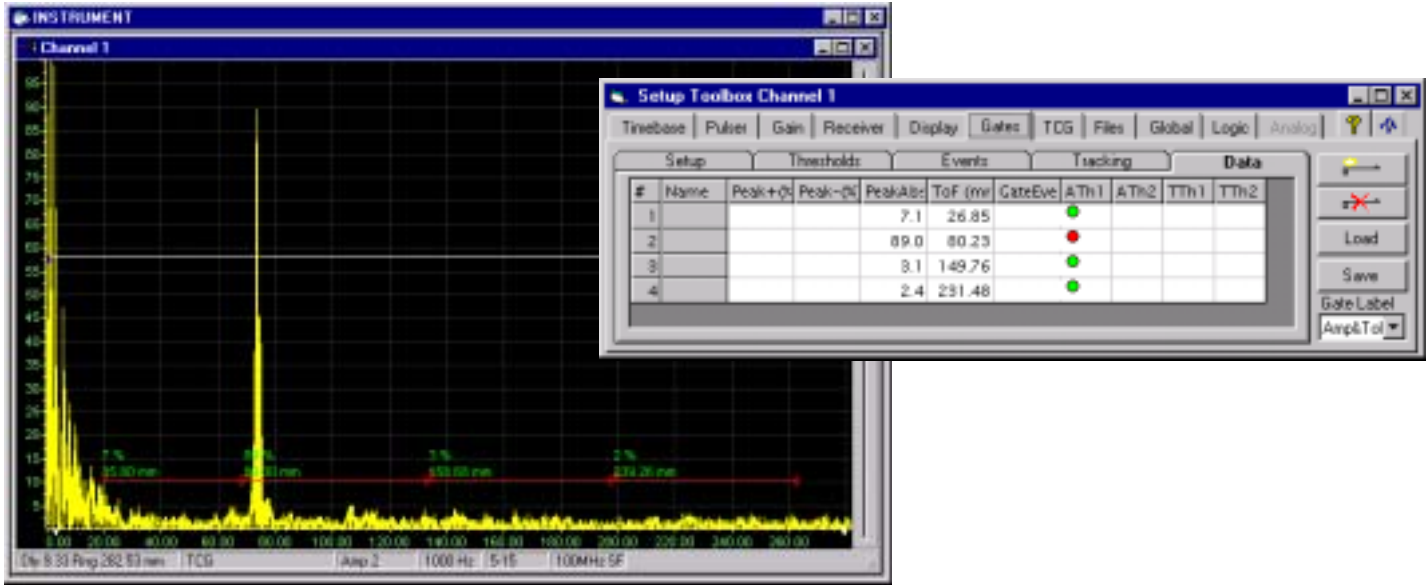
...or type in and fine-tune values directly in the TCG table.

#	Time (mm)	Gain (db)
1		63
2	94.63	21.8 X
3	136.01	28.6 X
4	174.39	32.2 X

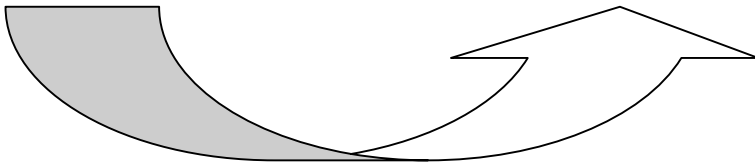
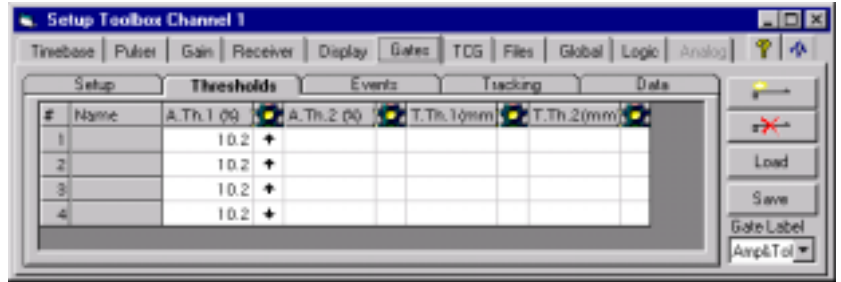


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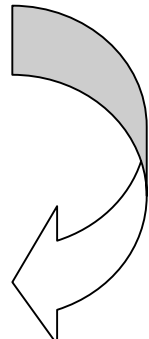
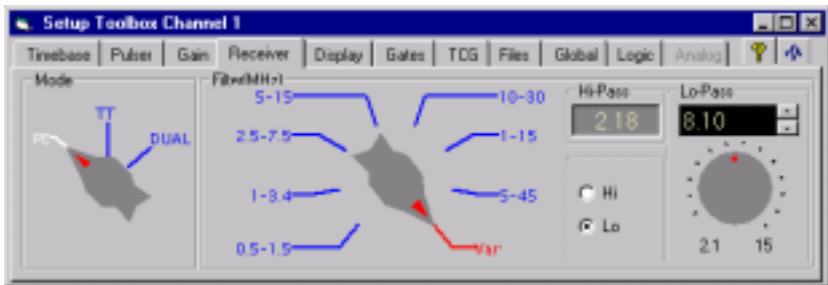
**Set 1-4 gates (1-32 optional) Delay, Range and Threshold
... using push-pulls icons on the screen display...**



**... or enter values numerically
into the Gates' table**



Variable electronic filter for optimizing transducer frequency response

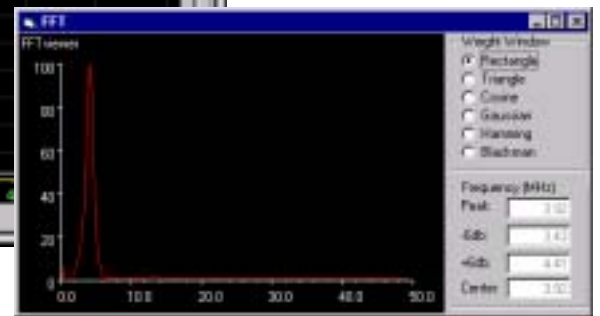


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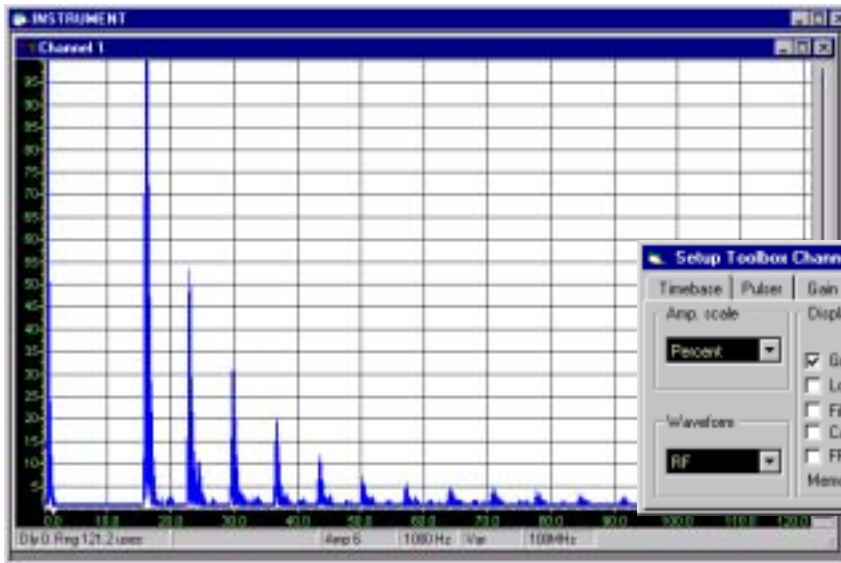
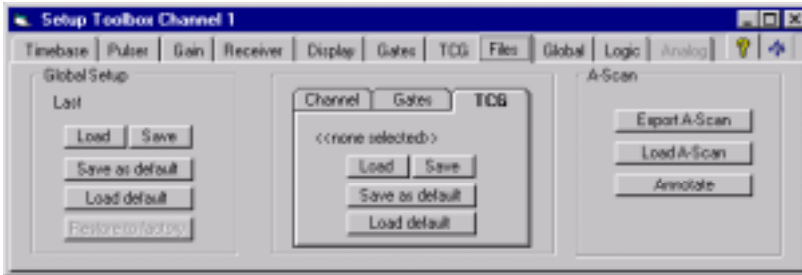
Use on-board tools for A-scan evaluation



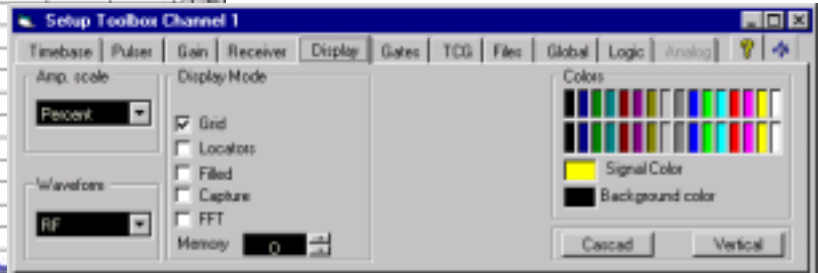
FFT viewer



Store and retrieve independent instrument, gate and TCG set-up files.



Select screen display colors



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Program instrument I/O and audio-visual alarm display

The screenshot shows the INSTRUMENT software interface. The main window displays a waveform plot for Channel 1 with two prominent peaks. A red arrow points from the text 'Audio visual alarms' to a 'Logic' window. This window contains two gates: Gate 1 (red) and Gate 2 (green), each with a 'Reset' button. Below the plot is the 'Setup Toolbox Channel 1' window, which has tabs for Timebase, Pulse, Gain, Receiver, Display, Gates, TDG, Files, Global, Logic, and Analog. It contains several tables for configuration:

Enabl	Script	Screen	Label	Buzzer	Out
ON	ga(1,1,1)	Light&Coun	Gate 1 (+)	ON	Upr Output1
ON	ga(1,2,1)	Light&Coun	Gate 2 (+)	ON	Upr Output1

Below the Setup Toolbox are two smaller windows: 'Outputs' and 'Inputs', both containing tables with columns for Delay, Duration, Units, Invert, Manual, and State.

Instrument I/O

... add application-specific inspection reports ...

The screenshot shows application-specific inspection reports. On the left is a 'Test Process' window with a table of Spot Plans:

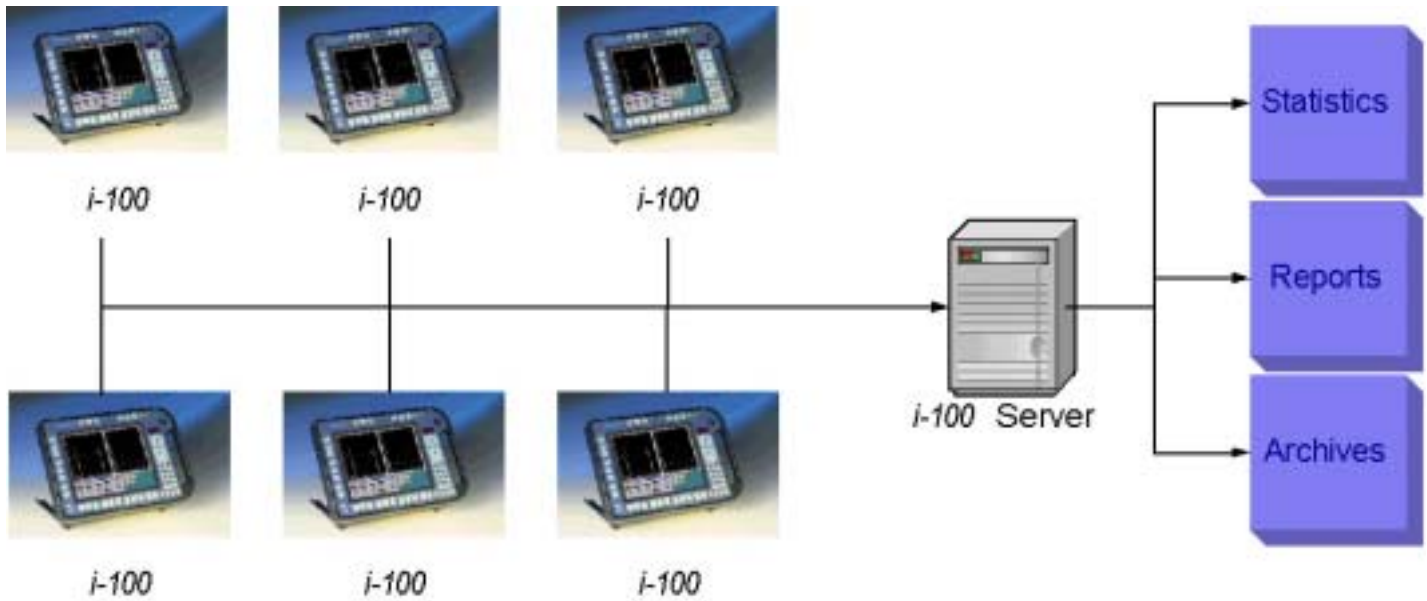
SpotPlan	Description
1	0.05/0.05 sec
2	0.05/0.05 sec
3	0.05/0.05 sec
4	0.05/0.05 sec
5	0.05/0.05 sec
6	0.05/0.05 sec
7	0.05/0.05 sec

In the center is a 'SVM Test Report: All Spots' window showing a graph of spot counts over time. On the right is a 'SVM Summary Test Report: Bad Spots' window with a detailed table of spot data:

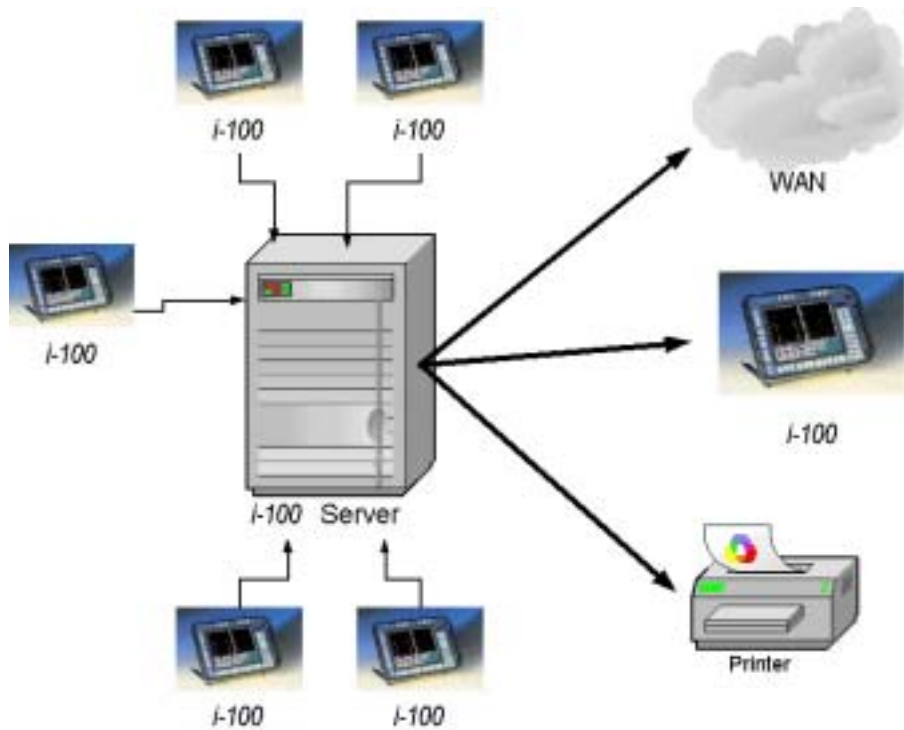
Spot Number	Description	Category	Threshold (sec)
1	4.45	Class 1	1.00
2	4.46	Class 1	1.00
3	4.47	Class 1	1.00
4	4.48	Class 1	1.00
5	4.49	Class 1	1.00
6	4.50	Class 1	1.00
7	4.51	Class 1	1.00
8	4.52	Class 1	1.00
9	4.53	Class 1	1.00
10	4.54	Class 1	1.00
11	4.55	Class 1	1.00
12	4.56	Class 1	1.00
13	4.57	Class 1	1.00
14	4.58	Class 1	1.00
15	4.59	Class 1	1.00
16	4.60	Class 1	1.00

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... networking capability ...



... and database management software ...



...to provide the productivity and competitive edge you are looking for in your inspection application



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i-100 TECHNICAL SPECIFICATION

Overall Analog Performance		Time Base		Data acquisition speed	
Analog bandwidth	1 to 35MHz (-3dB)	Range	100nsec to 10msec	Peak amplitude and time of flight	Up to 10M measurements/sec
Calibrated gain	95dB	Delay	0 to 10msec	Data Storage and Display	
Gain step size	0.2dB.	Resolution ¹⁾	10nsec	Hard disc drive	40GByte
Equivalent input noise	<6nV/√Hz	Hardware Gates		Built-in display (standard)	10.4" high brightness TFT color
Linearity	± 1dB	Number per channel	4, expandable to 32	Control device	Keyboard, mouse or trackball
Channels		Range	60nsec to 10msec	Remote control	Hand-held infra-red
Number of channels	1	Resolution ¹⁾	10nsec	Interfaces	
Channel triggering	Internal or external	Peak detection	Positive, negative or absolute	Hardware	External VGA USB
Pulsar Characteristics (RPP3)		Alarm threshold	Positive or negative going		Parallel
Excitation	Square wave	Dynamic gate	Backwall echo tracking in last gate		Ethernet
Amplitude	8 levels	DAC		General	
Max. pulse amplitude, 50Ω load	350V + 10%	Dynamic range	50dB	Power requirements	115V or 230V ± 10% 48-63Hz, 250VA
PRF per channel	1 to 10,000Hz	Amplitude resolution	0.2dB	Battery operation	Up to 2 hours continuous, with additional 'hot' swap' capability.
Damping	8 settings	Range	160nsec – 1msec	Operating temperature range	5 to 45°C
Stability	± 2% FSH	Timebase resolution	160nsec	Humidity	<95% non-condensing
Flatness	± 0.5dB	Position resolution	10nsec (first step)	Dimensions	400mm x 290mm x 100mm (16" x 10.8" x 4.3") - W:H:D
Mode	PE, TT	Slew rate	20dB/160nsec	Weight	~6.8Kg (15lbs)
Pulse fall time	< 5nsec	Interpolation	Linear between calibration points		
Single pulse width	10-500nsec	Last gate attenuator	Back wall echo attenuation		
Pulse width resolution	1nsec	Analog to Digital Conversion			
Burst	1,2,3,4	Resolution	10 bit (8 bit effective)		
Isolation (PE/TT)	> 65dB @ 5MHz	Sampling rates	12.5,25,50,100,200 (interleave) MSPs		
Preamplifier Characteristics		High speed buffer	1MByte		
Programmable gain	0, 15, 30, 45dB				
Frequency Filters					
Number and type of filters	7 fixed				

¹⁾ At 100 msp/s digitizing rate

OPTIONAL CONFIGURATIONS

i-100 HF

High-frequency bandwidth, 1-75MHz (-3dB)

i-100 XD

Enhanced dynamic range of 80dB.
Single-channel version only

i-100 P4

1-4 Channels with internal RPP4 pulser pre-amplifier (replaces RPP3).

* Specifications are subject to change without notice.

Corporate Offices

ScanMaster Systems (IRT), Ltd.

5B Ha'Nagar St., Neve Ne'eman B
45800 Hod Ha'Sharon, Israel
Phone: 972-9-7475
Fax: 972-9-7475444
Email: sales@scanmaster-irt.com
Web site: <http://www.scanmaster-irt.com>

IRT•ScanMaster Systems, Inc.

319 Garlington Road, Suite B4
Greenville, SC 29615, USA
Phone: (864) 288-9813
Fax: (864) 288-9799
e-mail: irtinc@irtscanmaster.com

